

Notice of References Cited	Application/Control No. 10/530,030		Applicant(s)/Patent Under Reexamination KANEGAE ET AL.	
	Examiner HENOK G. HEYI		Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,285,826 B1	09-2001	Murase et al.	386/125
*	B	US-6,985,411 B2	01-2006	Kanegae et al.	369/30.04
*	C	US-2006/0110132 A1	05-2006	Takakuwa et al.	386/095
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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